

**Notice of References Cited**

Application/Control No.

10/026,010

Applicant(s)/Patent Under  
Reexamination  
HAYDUK, MATTHEW A.

Examiner

Sharad Rampuria

Art Unit

2683

Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,591,116 B1	07-2003	Laurila et al.	455/558
	B	US-2002/0119776 A1	08-2002	Vestergaard et al.	455/436
	C	US-6,002,936 A	12-1999	Roel-Ng et al.	455/456.4
	D	US-6,141,547 A	10-2000	Rousseau et al.	455/426.1
	E	US-5,878,344 A	03-1999	Zicker, Robert G.	455/426.1
	F	US-2003/0013434 A1	01-2003	Rosenberg et al.	455/414
	G	US-6,397,065 B1	05-2002	Huusko et al.	455/435.2
	H	US-6,516,197 B2	02-2003	Havinis et al.	455/456.1
	I	US-6,594,488 B1	07-2003	Chow et al.	455/426.1
	J	US-6,654,362 B1	11-2003	Palamara, Maria E.	370/332
	K	US-2004/0132486 A1	07-2004	Halonen et al.	455/552.1
	L	US-2002/0061766 A1	05-2002	Sato et al.	455/552
	M	US-6,584,314 B1	06-2003	Haumont et al.	455/435.1

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	WO 200111911 A1	02-2001	World Intellect	BAECK et al.	H04Q 07/22
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.